

Application/Control No.	Applicant(s)/Patent under Reexamination
10/633,012	WANG ET AL.
Examiner	Art Unit
Isaac T. Tecklu	2192

	SEARCHED				
Class	Subclass	Date	Examiner		
717	140, 149, 151, 162	7/8/2007	ΙΤ		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Searched EAST all database	7/7/2007	IT		